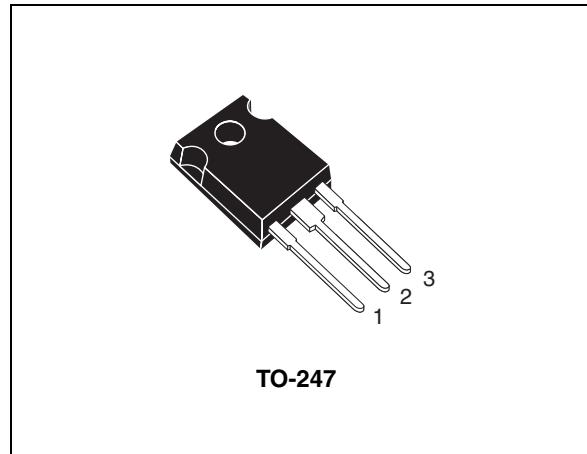


N-channel 650 V, 0.024  $\Omega$  84 A, MDmesh™ V Power MOSFET  
in TO-247

## Features

Order code	$V_{DSS}$ @ $T_{jmax}$	$R_{DS(on)}$ max.	$I_D$
STW88N65M5	710 V	< 0.029 $\Omega$	84 A

- Worldwide best  $R_{DS(on)}$  in TO-247
- Higher  $V_{DSS}$  rating
- Higher dv/dt capability
- Excellent switching performance
- Easy to drive
- 100% avalanche tested



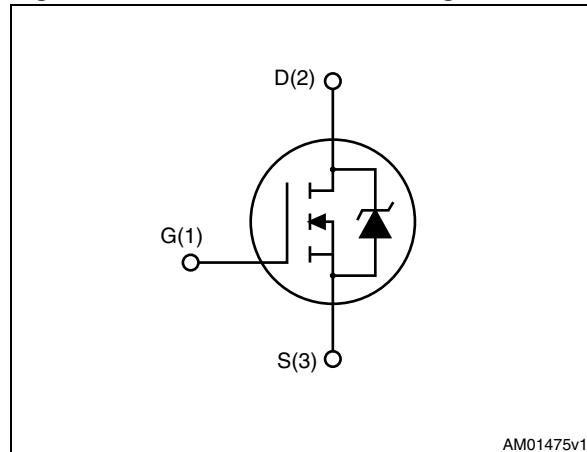
## Applications

- High efficiency switching applications: servers, PV inverters, telecom infrastructure, multi kW battery chargers.

## Description

This device is a N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESHTM horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

**Figure 1. Internal schematic diagram**



AM01475v1

**Table 1. Device summary**

Order code	Marking	Package	Packaging
STW88N65M5	88N65M5	TO-247	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate- source voltage	25	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	84	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	50.5	A
$I_{DM}^{(1)}$	Drain current (pulsed)	336	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	450	W
$I_{AR}$	Max current during repetitive or single pulse avalanche (pulse width limited by $T_{JMAX}$ )	15	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	2000	mJ
$dv/dt^{(2)}$	Peak diode recovery voltage slope	15	V/ns
$T_{stg}$	Storage temperature	- 55 to 150	$^\circ\text{C}$
$T_j$	Max. operating junction temperature	150	$^\circ\text{C}$

1. Pulse width limited by safe operating area
2.  $I_{SD} \leq 84\text{ A}$ ,  $di/dt = 400\text{ A}/\mu\text{s}$ , peak  $V_{DS} < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	0.28	$^\circ\text{C}/\text{W}$
$R_{thj-amb}$	Thermal resistance junction-ambient max	50	$^\circ\text{C}/\text{W}$
$T_l$	Maximum lead temperature for soldering purpose	300	$^\circ\text{C}$

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified)

**Table 4. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	650			V
$I_{\text{DSS}}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 650 \text{ V}$ $V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$			1 100	$\mu\text{A}$ $\mu\text{A}$
$I_{\text{GSS}}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 25 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{\text{DS}(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 42 \text{ A}$		0.024	0.029	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{\text{iss}}$ $C_{\text{oss}}$ $C_{\text{rss}}$	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0$	-	8825 223 11	-	pF pF pF
$C_{o(\text{tr})}^{(1)}$	Equivalent capacitance time related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 520 \text{ V}$	-	778	-	pF
$C_{o(\text{er})}^{(2)}$	Equivalent capacitance energy related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 520 \text{ V}$	-	202	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz open drain}$	-	1.79	-	$\Omega$
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 520 \text{ V}, I_D = 42 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 16</a> )	-	204 51 84	-	nC nC nC

- $C_{o(\text{tr})}$  is a constant capacitance value that gives the same charging time as  $C_{\text{oss}}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- $C_{o(\text{er})}$  is a constant capacitance value that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(V)}$	Voltage delay time	$V_{DD} = 400 \text{ V}$ , $I_D = 56 \text{ A}$ ,		141		ns
$t_{r(V)}$	Voltage rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$	-	16	-	ns
$t_{f(i)}$	Current fall time	(see <a href="#">Figure 17</a> )		29	-	ns
$t_{c(off)}$	Crossing time	(see <a href="#">Figure 20</a> )		56	-	ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		84	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				336	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 84 \text{ A}$ , $V_{GS} = 0$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 84 \text{ A}$ ,		544		ns
$Q_{rr}$	Reverse recovery charge	$dI/dt = 100 \text{ A}/\mu\text{s}$	-	14		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	$V_{DD} = 100 \text{ V}$ (see <a href="#">Figure 17</a> )		50		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 84 \text{ A}$ ,		660		ns
$Q_{rr}$	Reverse recovery charge	$dI/dt = 100 \text{ A}/\mu\text{s}$	-	20		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	$V_{DD} = 100 \text{ V}$ , $T_j = 150 \text{ }^\circ\text{C}$ (see <a href="#">Figure 17</a> )		60		A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

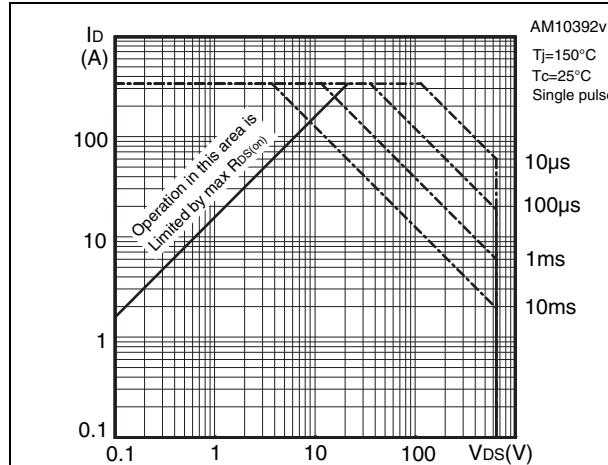


Figure 3. Thermal impedance

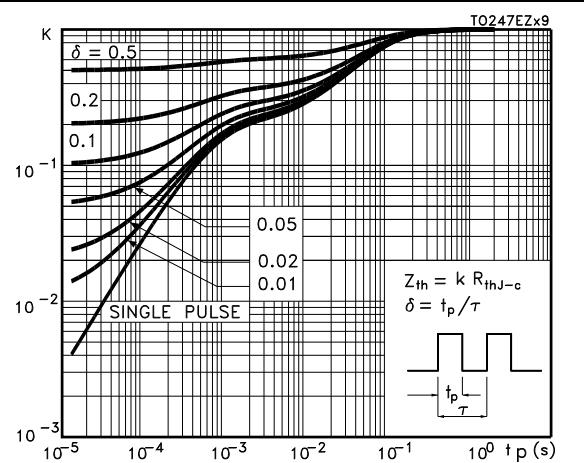


Figure 4. Output characteristics

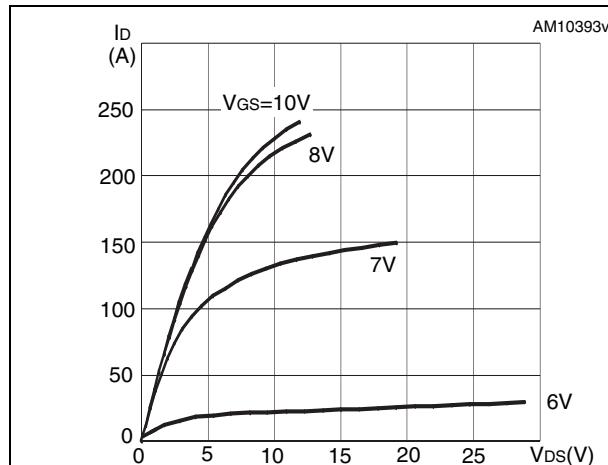


Figure 5. Transfer characteristics

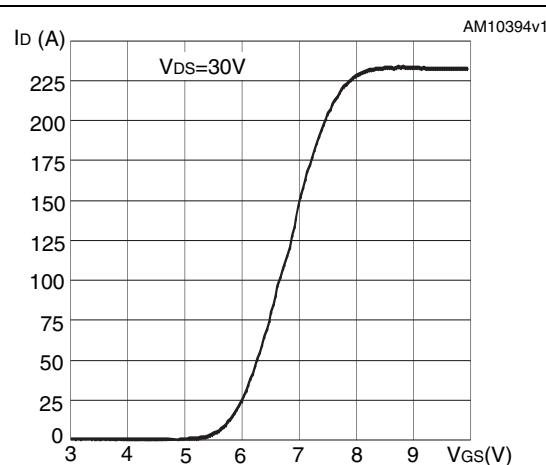


Figure 6. Gate charge vs gate-source voltage

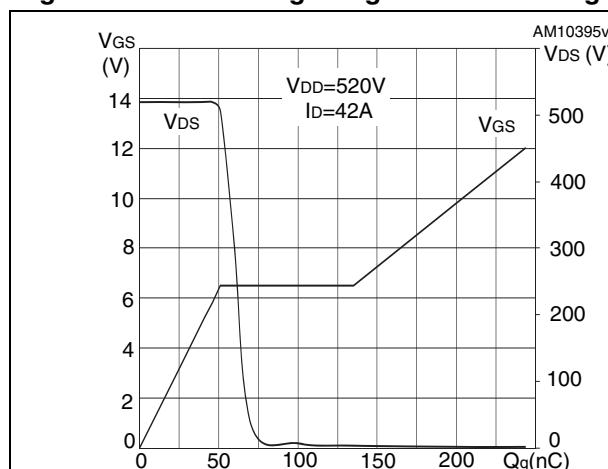
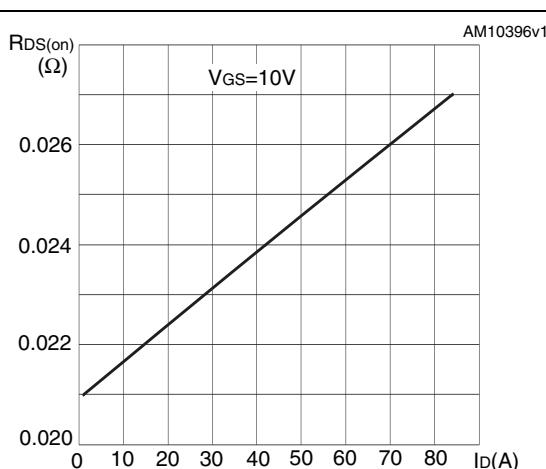
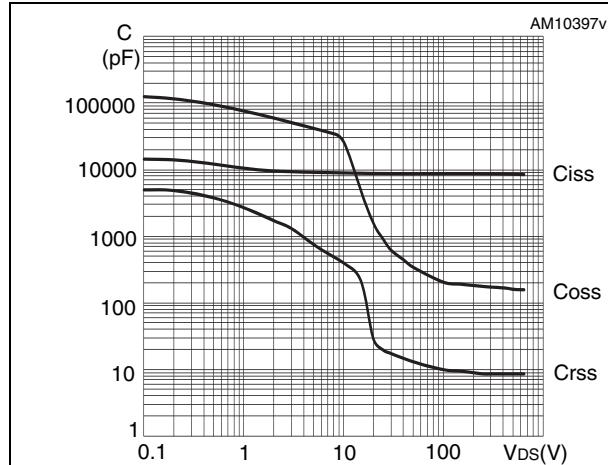
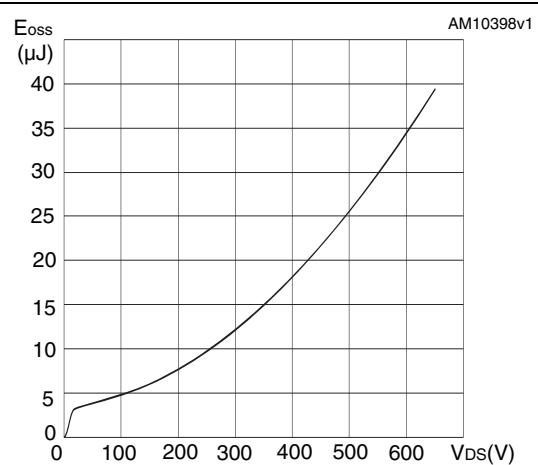
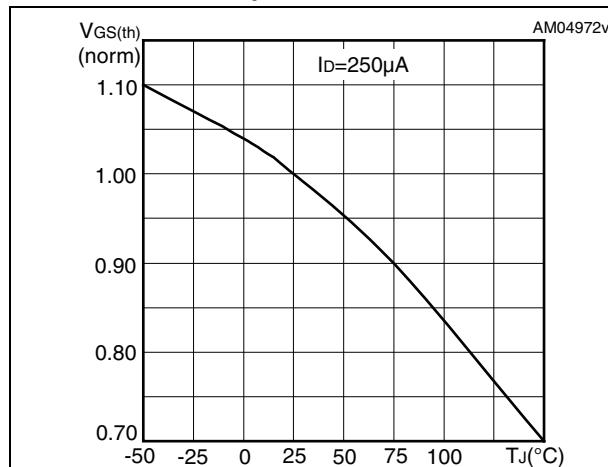
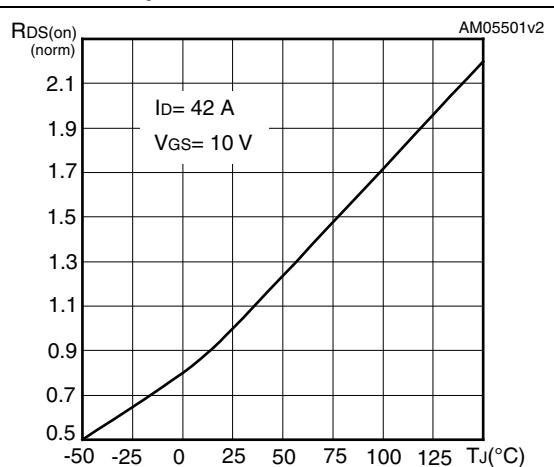
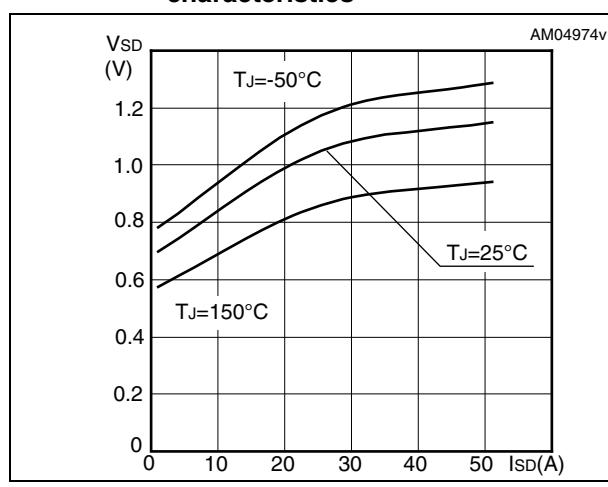
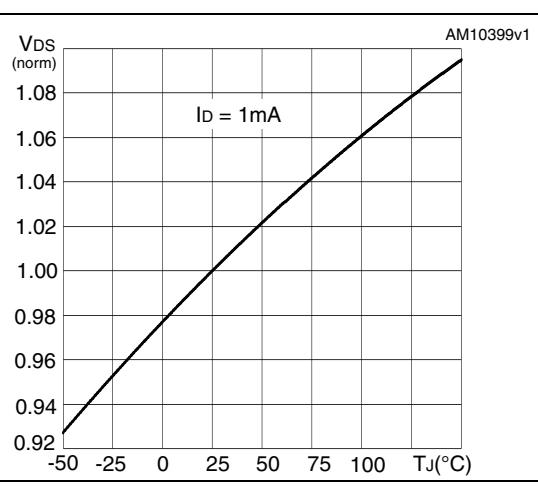
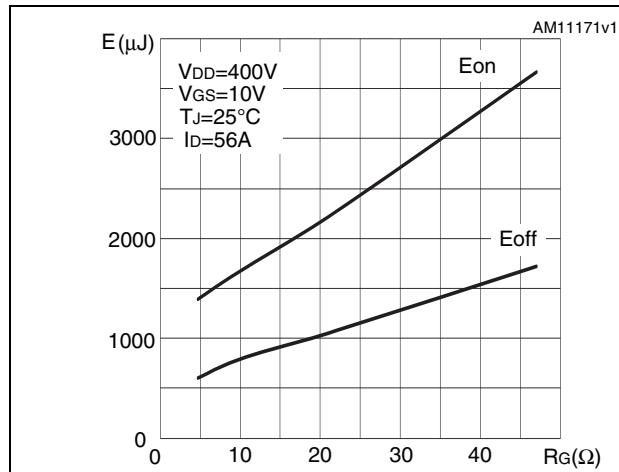


Figure 7. Static drain-source on resistance



**Figure 8. Capacitance variations****Figure 9. Output capacitance stored energy****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics****Figure 13. Normalized  $V_{DS}$  vs temperature**

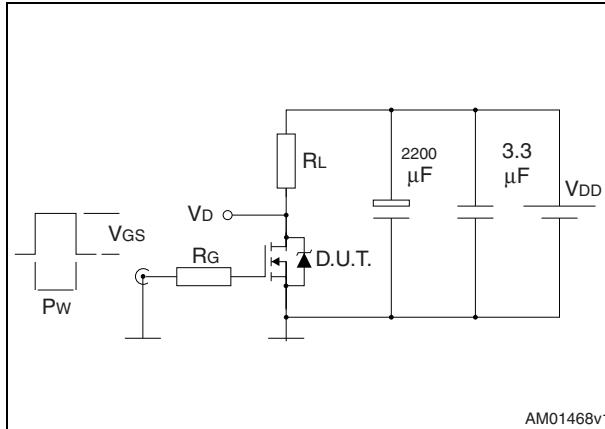
**Figure 14. Switching losses vs gate resistance  
(1)**



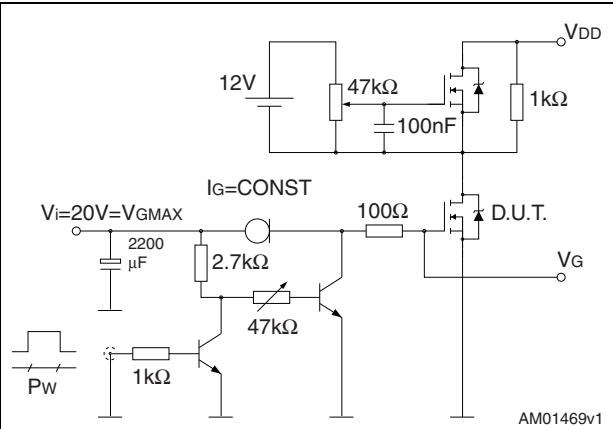
1.  $E_{on}$  including reverse recovery of a SiC diode

### 3 Test circuits

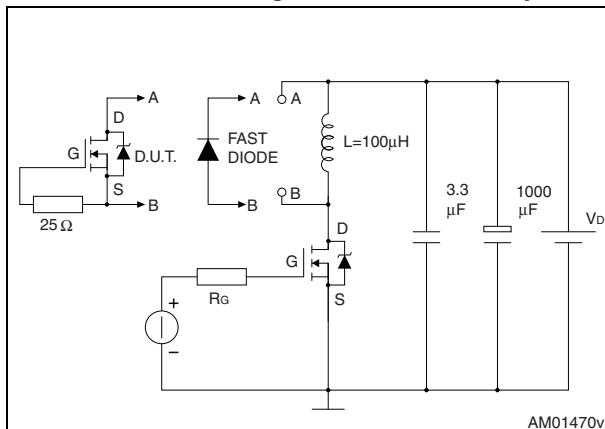
**Figure 15. Switching times test circuit for resistive load**



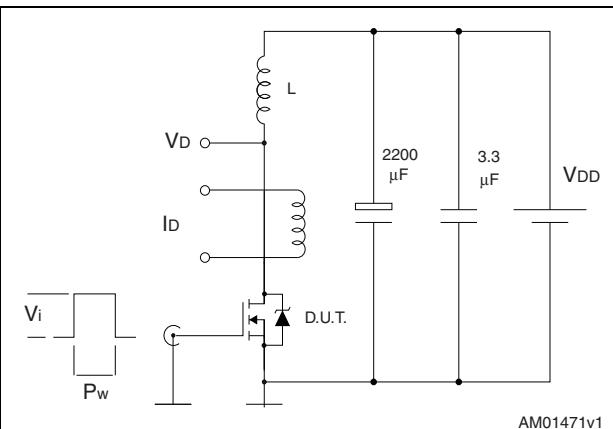
**Figure 16. Gate charge test circuit**



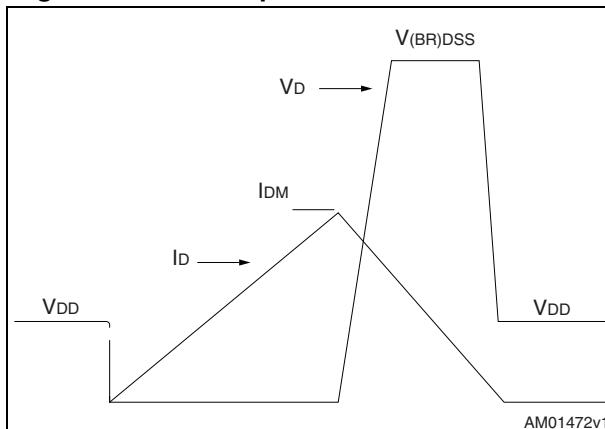
**Figure 17. Test circuit for inductive load switching and diode recovery times**



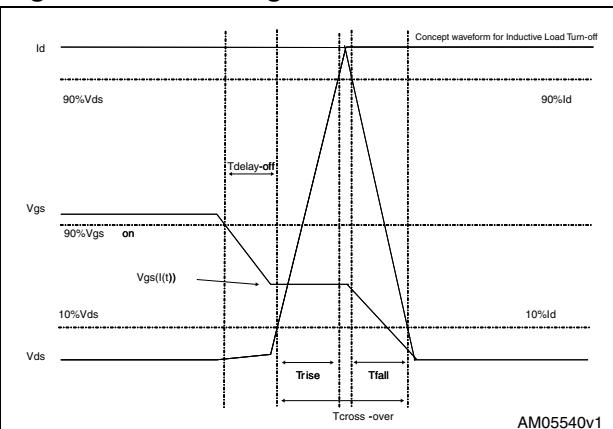
**Figure 18. Unclamped inductive load test circuit**



**Figure 19. Unclamped inductive waveform**



**Figure 20. Switching time waveform**



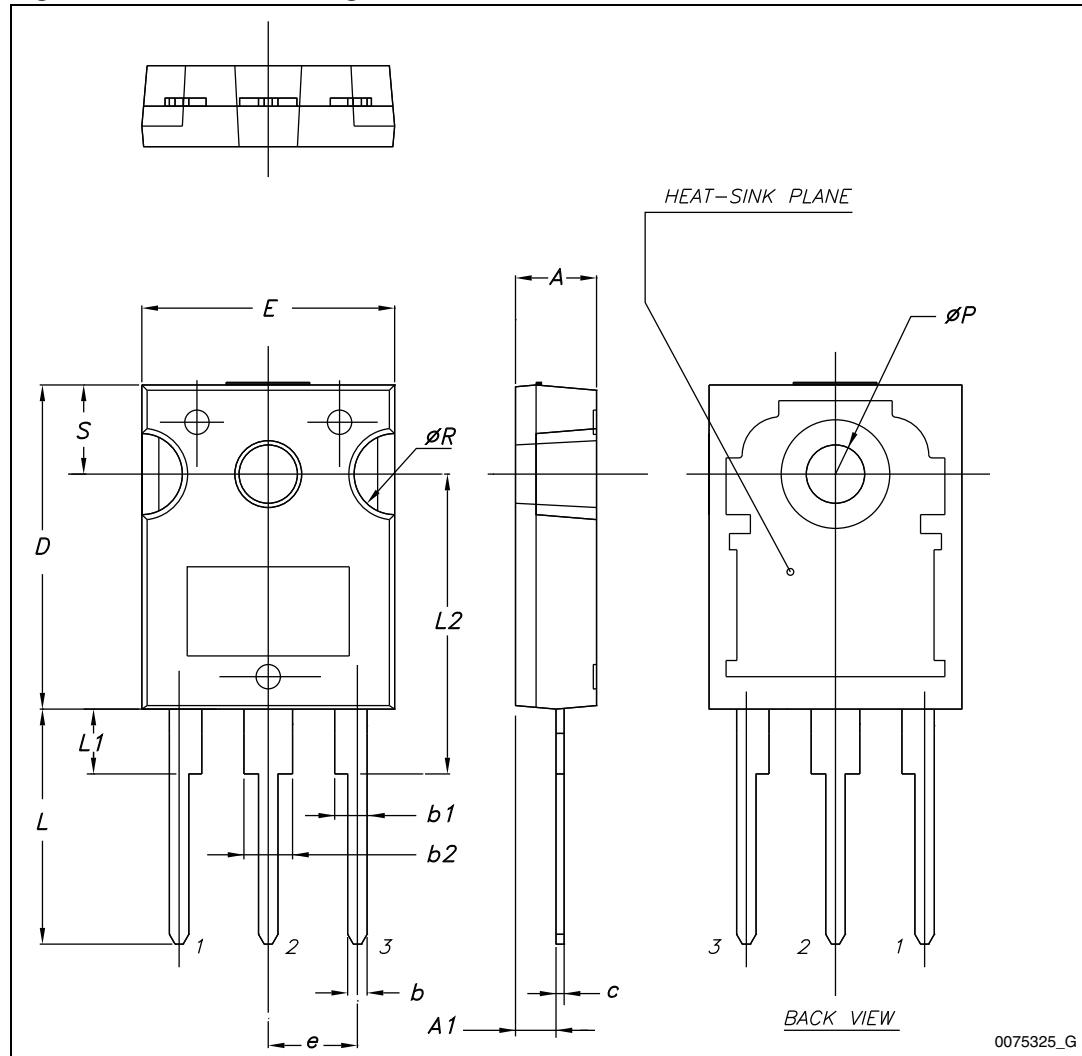
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

**Table 8.** TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 21. TO-247 drawing



## 5 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
23-Nov-2011	1	First release.
09-Dec-2011	2	Document status promoted from preliminary data to datasheet.

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